

Notice of References Cited	Application/Control No. <div style="text-align: center;">09/865,023</div>		Applicant(s)/Patent Under Reexam <div style="text-align: center;">Aven et al</div>	
	Examiner <div style="text-align: center;">S. Mark Clardy</div>		Art Unit <div style="text-align: center;">1616</div>	Page 1 of 1

U.S. PATENT DOCUMENTS

	Document Number <small>Country Code-Number-Kind Code</small>	Date <small>MM-YYYY¹</small>	Name	Classification ²	
A	6,448,204	9/2002	Maier et al	504	250
B					
C					
D					
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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